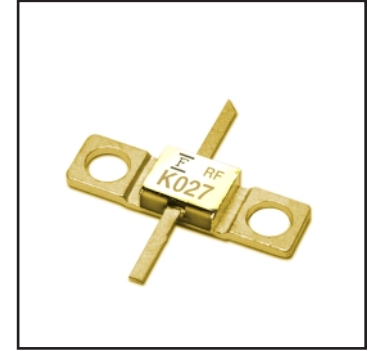


FEATURES

- High Output Power: $P_{1dB} = 24.0dBm$ (Typ.)
- High Gain: $G_{1dB} = 7.0dB$ (Typ.)
- High PAE: $\eta_{add} = 32%$ (Typ.)
- Proven Reliability
- Hermetic Metal/Ceramic Package

DESCRIPTION

The FLK027WG is a power GaAs FET that is designed for general purpose applications in the Ku-Band frequency range as it provides superior power, gain, and efficiency.



Fujitsu's stringent Quality Assurance Program assures the highest reliability and consistent performance.

ABSOLUTE MAXIMUM RATING (Ambient Temperature $T_a=25^\circ C$)

| Item | Symbol | Condition | Rating | Unit |
|-------------------------|-----------|--------------------|-------------|------------|
| Drain-Source Voltage | V_{DS} | | 15 | V |
| Gate-Source Voltage | V_{GS} | | -5 | V |
| Total Power Dissipation | P_T | $T_C = 25^\circ C$ | 1.875 | W |
| Storage Temperature | T_{stg} | | -65 to +175 | $^\circ C$ |
| Channel Temperature | T_{ch} | | 175 | $^\circ C$ |

Fujitsu recommends the following conditions for the reliable operation of GaAs FETs:

1. The drain-source operating voltage (V_{DS}) should not exceed 10 volts.
2. The forward and reverse gate currents should not exceed 2.2 and -0.1 mA respectively with gate resistance of 2000 Ω .
3. The operating channel temperature (T_{ch}) should not exceed 145 $^\circ C$.

ELECTRICAL CHARACTERISTICS (Ambient Temperature $T_a=25^\circ C$)

| Item | Symbol | Test Conditions | Limit | | | Unit |
|-------------------------------|--------------|---|-------|------|------|--------------|
| | | | Min. | Typ. | Max. | |
| Saturated Drain Current | I_{DSS} | $V_{DS} = 5V, V_{GS} = 0V$ | - | 100 | 150 | mA |
| Transconductance | g_m | $V_{DS} = 5V, I_{DS} = 65mA$ | - | 50 | - | mS |
| Pinch-off Voltage | V_p | $V_{DS} = 5V, I_{DS} = 5mA$ | -1.0 | -2.0 | -3.5 | V |
| Gate Source Breakdown Voltage | V_{GSO} | $I_{GS} = -5\mu A$ | -5 | - | - | V |
| Output Power at 1dB G.C.P. | P_{1dB} | $V_{DS} = 10V,$ $I_{DS} = 0.6 I_{DSS}$ (Typ.), $f = 14.5$ GHz | 23.0 | 24.0 | - | dBm |
| Power Gain at 1dB G.C.P. | G_{1dB} | | 6.0 | 7.0 | - | dB |
| Power-added Efficiency | η_{add} | | - | 32 | - | % |
| Output Power at 1dB G.C.P. | P_{1dB} | $V_{DS} = 10V,$ $I_{DS} = 0.6 I_{DSS}$ (Typ.), $f = 12$ GHz | - | 24 | - | dBm |
| Power Gain at 1dB G.C.P. | G_{1dB} | | - | 8 | - | dB |
| Power-added Efficiency | η_{add} | | - | 34 | - | % |
| Thermal Resistance | R_{th} | Channel to Case | - | 40 | 80 | $^\circ C/W$ |

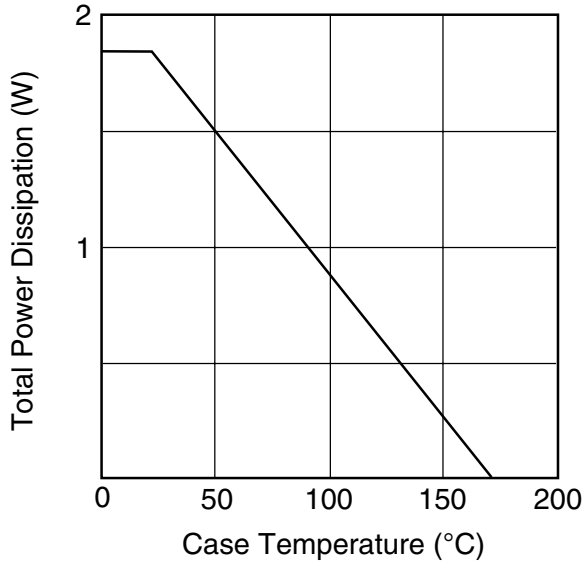
CASE STYLE: WG

G.C.P.: Gain Compression Point

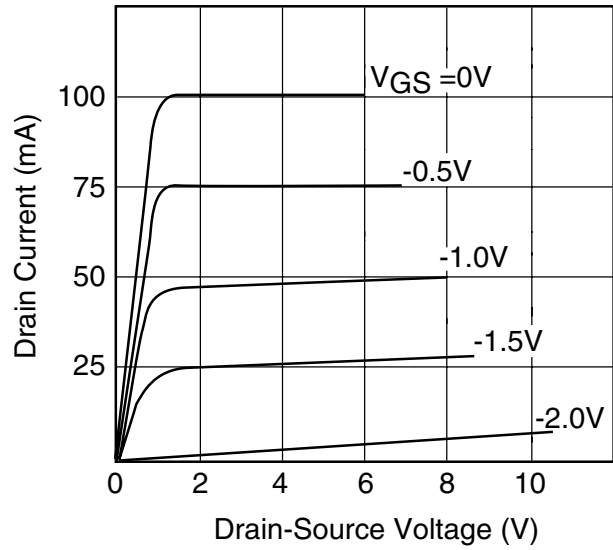
FLK027WG

X, Ku Band Power GaAs FET

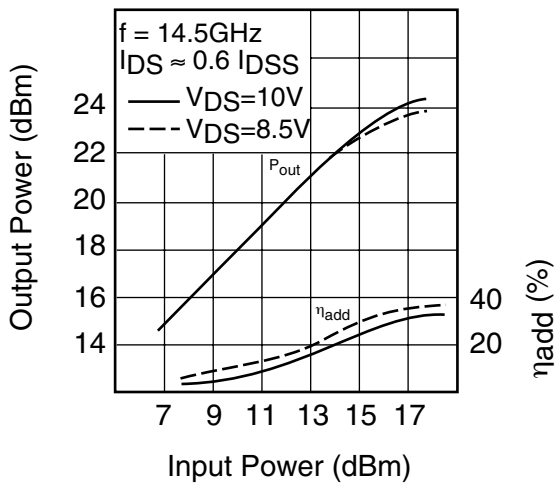
POWER DERATING CURVE



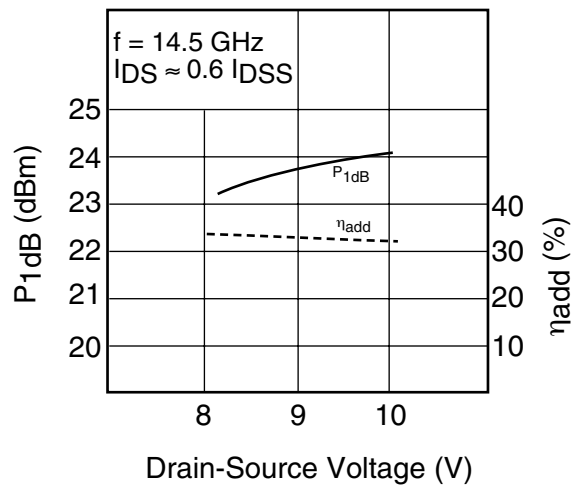
DRAIN CURRENT vs. DRAIN-SOURCE VOLTAGE



OUTPUT POWER vs. INPUT POWER

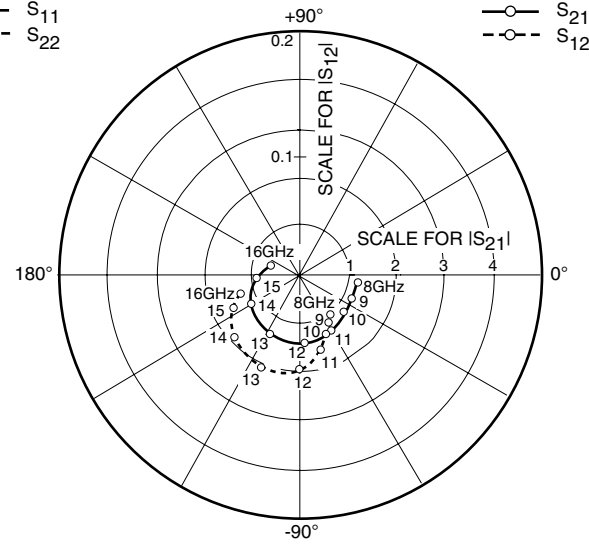
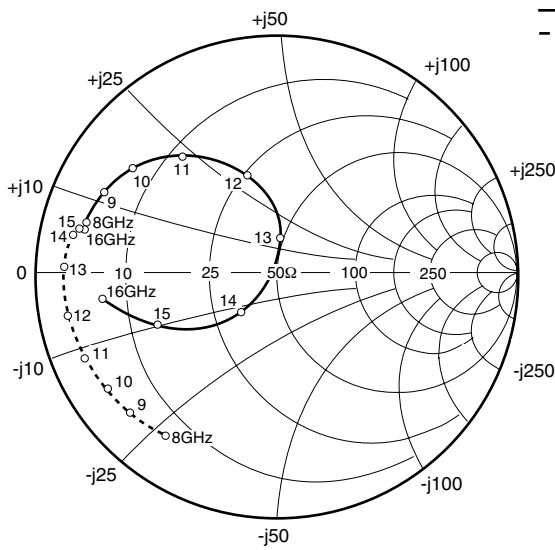


P_{1dB} & η_{add} vs. V_{DS}



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X, Ku Band Power GaAs FET



S-PARAMETERS

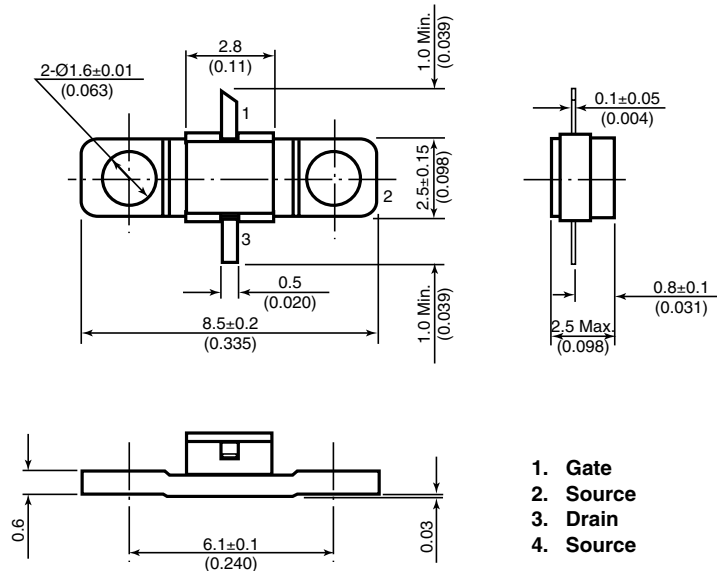
$V_{DS} = 10V, I_{DS} = 60mA$

| FREQUENCY (MHZ) | S11 | | S21 | | S12 | | S22 | |
|--------------------|------|--------|-------|--------|------|--------|------|--------|
| | MAG | ANG | MAG | ANG | MAG | ANG | MAG | ANG |
| 500 | .985 | -31.8 | 4.381 | 156.3 | .011 | 67.8 | .758 | -13.7 |
| 1000 | .965 | -60.1 | 3.965 | 134.7 | .021 | 48.5 | .748 | -27.2 |
| 8000 | .819 | 165.4 | 1.204 | -8.3 | .041 | -54.3 | .825 | -123.9 |
| 8500 | .804 | 159.8 | 1.177 | -16.6 | .043 | -56.1 | .832 | -130.0 |
| 9000 | .787 | 155.0 | 1.161 | -24.5 | .046 | -58.6 | .838 | -135.6 |
| 9500 | .766 | 150.1 | 1.164 | -32.1 | .049 | -61.0 | .842 | -140.2 |
| 10000 | .735 | 144.2 | 1.197 | -40.4 | .053 | -63.6 | .853 | -144.8 |
| 10500 | .689 | 137.4 | 1.248 | -49.7 | .058 | -68.7 | .864 | -149.6 |
| 11000 | .623 | 128.7 | 1.309 | -60.3 | .065 | -74.0 | .871 | -155.0 |
| 11500 | .534 | 118.5 | 1.364 | -72.9 | .072 | -81.9 | .878 | -161.4 |
| 12000 | .423 | 106.5 | 1.407 | -86.4 | .078 | -90.5 | .885 | -167.8 |
| 12500 | .290 | 93.9 | 1.413 | -101.2 | .082 | -101.5 | .886 | -174.6 |
| 13000 | .139 | 82.0 | 1.380 | -116.8 | .083 | -112.3 | .882 | 178.7 |
| 13500 | .036 | -123.8 | 1.304 | -133.2 | .080 | -123.7 | .875 | 173.0 |
| 14000 | .223 | -131.8 | 1.190 | -149.4 | .075 | -136.1 | .861 | 169.2 |
| 14500 | .395 | -144.2 | 1.041 | -164.5 | .068 | -145.6 | .849 | 167.8 |
| 15000 | .542 | -155.7 | .893 | -177.4 | .061 | -152.8 | .842 | 167.4 |
| 15500 | .652 | -164.2 | .757 | 172.1 | .054 | -156.1 | .832 | 167.6 |
| 16000 | .734 | -170.9 | .655 | 163.3 | .052 | -160.8 | .829 | 167.3 |

FLK027WG

X, Ku Band Power GaAs FET

Case Style "WG" Metal-Ceramic Hermetic Package



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- Do not put these products into the mouth.
- Do not alter the form of this product into a gas, powder, or liquid through burning, crushing, or chemical processing as these by-products are dangerous to the human body if inhaled, ingested, or swallowed.
- Observe government laws and company regulations when discarding this product. This product must be discarded in accordance with methods specified by applicable hazardous waste procedures.

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